

Notice of References Cited

Application/Control No.

09/916,511

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

EDMUND H. LEE

Art Unit

1732

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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NON-PATENT DOCUMENTS

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